Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/649,738	CHOI ET AL.
Examiner	Art Unit
Mike Oi	2871

SEARCHED			
Class	Subclass	Date	Examiner
349	123,132 133,134 172,99 100	1/3/2006	ZQQ
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
East search US-PGPUB;USPAT;USOCR; EPO;JPO;DERWENT;IBM_TDB; update search (see search history printout)	1/3/2006	zqq